

# **Enhancement Mode N-Channel Power MOSFET**

PDFN5X6/NMOS/40V/ $\pm$ 20V/1.7V/40A/7.5m $\Omega$ 

Rev<sub>0.5</sub>





# 40V, $7.5m\Omega$ , 40A, N-Channel MOSFET

#### 1.Features

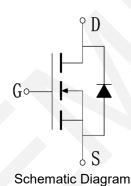
- ◆ 40V MOSFET technology
- ◆ Low on-state resistance
- Fast switching
- ♦ Vgs±20V

2.App	lications
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- ♦ Power Switching Application
- Load Switching



V <sub>DS</sub>	R <sub>DS(on)</sub> Typ.	I <sub>D</sub> Max.
40V	7.5mΩ @ 10V	404
	10.2mΩ @ 4.5V	40A



## 3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP4050KPA	WP4050KPA	PDFN5X6	5,000	50,000

#### 4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	$V_{DSS}$	40	V
Gate to Source Voltage	$V_{GSS}$	±20	V
Drain Current (DC)	I <sub>D</sub>	40	Α
Drain Current (Pulse), PW≤300μs	I <sub>DP</sub>	160	Α
Total Dissipation	P <sub>D</sub>	64	W
Avalanche Energy, Single Pulsed	E <sub>AS</sub>	110	mJ
Junction Temperature	Tj	150	°C
Storage Temperature	T <sub>stg</sub>	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



#### 5. Thermal Resistance Ratings

Parameter	Symbol	Value	Unit
Junction to case	R <sub>eJC</sub>	1.69	°C/W

Note 2: When mounted on 1 inch square copper board  $t \le 10$ sec The value in any given application depends on the user's specific board design.

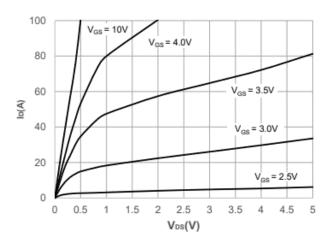
#### 6.Electrical Characteristics at Ta=25°C (Note 3)

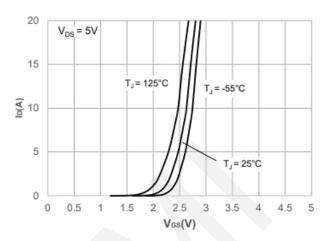
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V <sub>(BR)DSS</sub>	I <sub>D</sub> = 250μA, V <sub>GS</sub> = 0V	40	-	-	V
Zero-Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 40V, V <sub>GS</sub> = 0V	-	-	1	μA
Gate to Source Leakage Current	I <sub>GSS1</sub>	$V_{GS} = \pm 20V, V_{SS} = 0V$	-	-	±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =250μA	1.0	1.7	2.5	V
Static Drain to Source On-State	Б	I <sub>D</sub> = 30A, V <sub>GS</sub> = 10V	-	7.5	11	mΩ
Resistance	R <sub>DS(on)</sub>	I <sub>D</sub> = 20A, V <sub>GS</sub> = 4.5V	-	10.2	16	mΩ
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> =0V,		2419		pF
Output Capacitance	Coss	V <sub>DS</sub> =20V,		713		pF
Reverse Transfer Capacitance	C <sub>rss</sub>	Frequency=1.0MHz		535		pF
Turn-ON Delay Time	t <sub>d(on)</sub>	V <sub>DS</sub> = 20V,		12		ns
Rise Time	t <sub>r</sub>	$I_D = 30A$ ,		11		ns
Turn-OFF Delay Time	t <sub>d(off)</sub>	V <sub>GS</sub> = 10V,		39		ns
Fall Time	t <sub>f</sub>	$R_G = 3\Omega$		12		ns
Total Gate Charge	Qg	$V_{DS} = 20V,$ $V_{GS} = 10V,$ $I_{D} = 30A$		54.3		nC
	Q <sub>gs</sub>			6.9		nC
	Q <sub>gd</sub>			14.5		nC
Diode Forward Voltage	V <sub>FSD</sub>	I <sub>S</sub> = 30A, V <sub>GS</sub> = 0	0.4	0.9	1.2	V

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



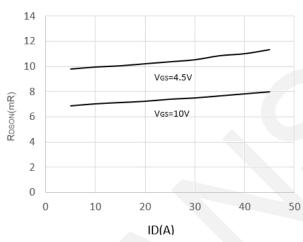
### 7. Typical electrical and thermal characteristics

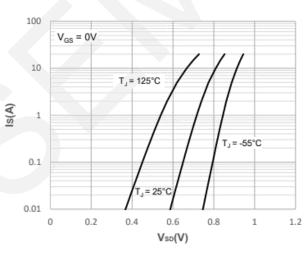




**Output Characteristics** 

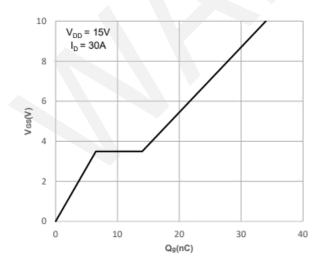
**Typical Transfer Characteristics** 

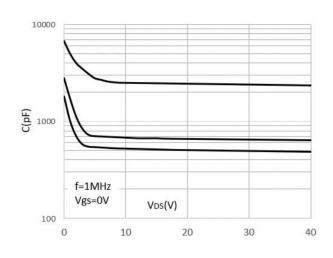




**On-resistance vs. Drain Current** 

**Body Diode Characteristics** 

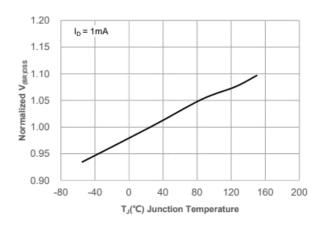




**Gate Charge Characteristics** 

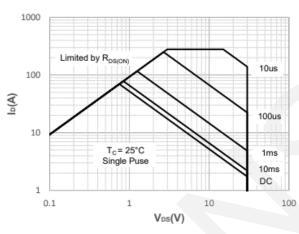
**Capacitance Characteristics** 



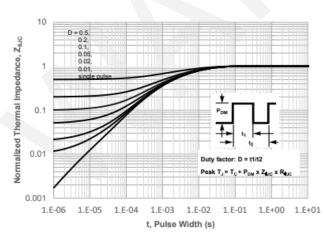


Normalized Breakdown Voltage vs.

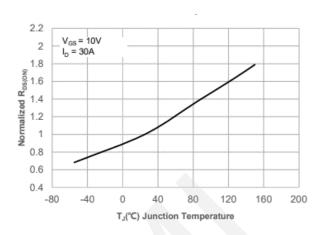
Junction Temperature



**Maximum Safe Operating Area** 

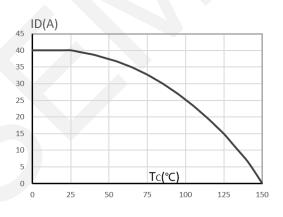


Normalized Maximum Transient
Thermal Impedance



Normalized on Resistance vs.

Junction Temperature

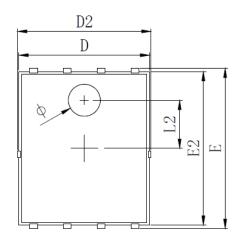


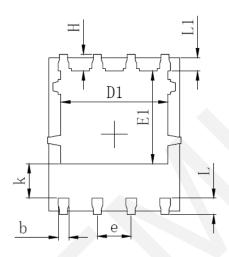
Maximum Continuous Drain Current vs.

Case Temperature



## 8.Package Dimensions





SYMBOL	MILLIMETER			
SIMDUL	MIN	Тур.	MAX	
A	0. 900	1. 000	1. 100	
A1		0.254 REF.		
A2		0~0.05		
D	4. 824	4. 900	4. 976	
D1	3. 910	4. 010	4. 110	
D2	4. 924	5. 000	5. 076	
Е	5. 924	6. 000	6. 076	
E1	3. 375	3. 475	3. 575	
E2	5. 674	5. 750	5. 826	
b	0. 350	0.400	0.450	
е	1.270 TYP.			
L	0. 534	0.610	0. 686	
L1	0. 424	0. 500	0. 576	
L2	1.800 REF.			
k	1. 190	1. 290	1. 390	
Н	0. 549	0. 625	0. 701	
θ	8°	10°	12°	
ф	1. 100	1. 200	1.300	
d			0. 100	



#### 9. Important Notice

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